

	Hits	Search Text	DBs
47	0	((resist or photoresist) near16 pattern\$4) and ((Aluminum or TFT or transistor or Ti or titanium or Mb or molybdenum or Ta or tantulum or tungsten or metal\$4 or conductive or gate) same (resist or photoresist) same (pattern\$3 or mask) same (etch\$4 or RIE or ash\$4)) and ((resist or photoresist) same strip\$6 same (resid\$4 or remain\$5) same (amino\$4ethanol near20 glycon near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
48	0	((resist or photoresist) same strip\$6 same (resid\$4 or remain\$5) same (amino\$4ethanol near20 glycon near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
49	0	((resist or photoresist) same strip\$6 same (amino\$4ethanol near20 glycon near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
50	11	((resist or photoresist) same strip\$6 same (amino\$4ethanol near20 glycol near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
51	3	((resist or photoresist) same strip\$6) and (strip\$4 same (amino\$4 near4 ethanol near20 glycol near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB

	Hits	Search Text	DBs
52	1	((resist or photoresist) near16 pattern\$4) and ((Aluminum or TFT or transistor or Ti or titanium or Mb or molybdenum or Ta or tantulum or tungsten or metal\$4 or conductive or gate) same (resist or photoresist) same (pattern\$3 or mask) same (etch\$4 or RIE or ash\$4)) and ((resist or photoresist) same strip\$6 same (resid\$4 or remain\$5) same (amino\$4ethanol near20 glycol near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
53	11	((resist or photoresist) same strip\$6) and (strip\$4 same (amino\$4ethanol near20 glycol near4 ether))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB
54	25	((resist or photoresist) same strip\$6) and (strip\$4 same ((amino\$4ethanol near20 glycol near4 ether) or (Nagase near4 strip\$4)))	US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB